

RoHS

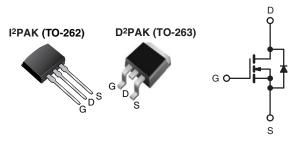
COMPLIANT

HALOGEN

**FREE** 

## Power MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	60				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 5 V 0.20				
Q <sub>g</sub> (Max.) (nC)	8.4				
Q <sub>gs</sub> (nC)	3.5				
Q <sub>gd</sub> (nC)	6.0				
Configuration	Single				



N-Channel MOSFET

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 **Definition**
- Advanced Process Technology
- Surface Mount (IRLZ14S, SiHLZ14S)
- Low-Profile Through-Hole (IRLZ14L, SiHLZ14L)
- 175 °C Operating Temperature
- Fast Switching
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay utilize advanced processing techniques to achieve extermely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that Power MOSFETs are well known for, provides the designer with an extremely efficient reliable device for use in a wide variety of applications.

The D<sup>2</sup>PAK is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and lowest possible on-resistance in any existing surface mount package. The D2PAK is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0 W in a typical surface mount application.

The through-hole version (IRLZ44L, SiHLZ44L) is available for low-profile applications.

ORDERING INFORMATION					
Package	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	D <sup>2</sup> PAK (TO-263)	I <sup>2</sup> PAK (TO-262)	
Lead (Pb)-free and Halogen-free	SiHLZ14S-GE3	SiHLZ14STRL-GE3a	SiHLZ14STRR-GE3a	-	
Lead (Pb)-free	IRLZ14SPbF	-	IRLZ14STRRPbFa	IRLZ14LPbF	
Lead (FD)-life	SiHLZ14S-E3	-	SiHLZ14STR-E3	SiHLZ14L-E3	

See device orientation.

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage <sup>e</sup>			$V_{DS}$	60	V	
Gate-Source Voltage			$V_{GS}$	± 10	V	
Continuous Drain Current	\/ at 5 \/	$V_{GS}$ at 5 V $T_C = 25 ^{\circ}C$ $T_C = 100 ^{\circ}C$	I <sub>D</sub>	10	А	
Continuous Drain Current	V <sub>GS</sub> at 5 V			7.2		
Pulsed Drain Current <sup>a, e</sup>			I <sub>DM</sub>	40		
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy <sup>b, e</sup>			E <sub>AS</sub>	68	mJ	
Maximum Dawar Dissination	T <sub>C</sub> =	T <sub>C</sub> = 25 °C		43	W	
Maximum Power Dissipation	T <sub>A</sub> = 25 °C		$P_{D}$	3.7	7 vv	
Peak Diode Recovery dV/dtc, e			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	Recommendations (Peak Temperature) for 10 s		Ĭ	300 <sup>d</sup>	7	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}=25$  V, starting T<sub>J</sub> = 25 °C, L = 790  $\mu$ H, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 10 A (see fig. 12). c. I<sub>SD</sub> ≤ 10 A, dI/dt ≤ 90 A/ $\mu$ s, V<sub>DD</sub> ≤ V<sub>DS</sub>, T<sub>J</sub> ≤ 175 °C. d. 1.6 mm from case.

- Uses IRLZ14, SiHLZ14 data and test conditions.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRLZ14S, IRLZ14L, SiHLZ14S, SiHLZ14L

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.5		

### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0$ , $I_D = 250 \mu A$		60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.07	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =	· V <sub>GS</sub> , I <sub>D</sub> = 250 μA	1.0	-	2.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 10 V	-	-	± 100	nA
Zoro Coto Voltago Droin Current	1	V <sub>DS</sub> :	= 60 V, V <sub>GS</sub> = 0 V	-	-	25	μA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 48 \text{ V}$	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C	-	-	250	μΑ
Drain-Source On-State Resistance	Б	V <sub>GS</sub> = 5 V	I <sub>D</sub> = 6.0 A <sup>b</sup>	-	-	0.2	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4 V	I <sub>D</sub> = 5.0 A <sup>b</sup>	-	-	0.28	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> :	= 25 V, I <sub>D</sub> = 6.0 A	3.5	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		V <sub>GS</sub> = 0 V,	-	400	-	
Output Capacitance	C <sub>oss</sub>	]	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0  MHz,  see fig. 5		170	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.			42	-	
Total Gate Charge	Qg			-	-	8.4	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 5 V	$V_{GS} = 5 \text{ V}$ $I_{D} = 10 \text{ A}, V_{DS} = 48 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	3.5	nC
Gate-Drain Charge	$Q_{gd}$		goo ng. o ana ro	-	-	6.0	1
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> = 30 V, I <sub>D</sub> = 10 A,		-	9.3	-	
Rise Time	t <sub>r</sub>			-	110	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_g = 12 \Omega$ ,	$R_D = 2.8 \Omega$ , see fig. $10^b$	-	17	-	ns
Fall Time	t <sub>f</sub>			-	26	-	
Internal Source Inductance	L <sub>S</sub>	Between lead	, and center of die contact	-	7.5	-	nH
Drain-Source Body Diode Characteristic	es						
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	A
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	40	
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C	C, I <sub>S</sub> = 10 A, V <sub>GS</sub> = 0 V <sup>b</sup>	-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 00 1	10 A 41/4+ 100 A/h	-	93	130	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25  ^{\circ}\text{C}, I_F = 10  \text{A},  \text{dl/dt} = 100  \text{A/} \mu \text{s}^{\text{b}}$		-	340	650	nC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )			1 - \		

### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq$  300  $\mu$ s; duty cycle  $\leq$  2 %.

### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

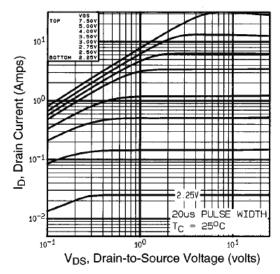


Fig. 1 - Typical Output Characteristics

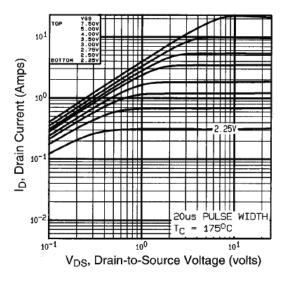


Fig. 2 - Typical Output Characteristics

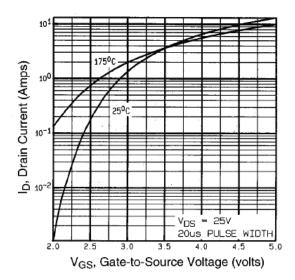


Fig. 3 - Typical Transfer Characteristics

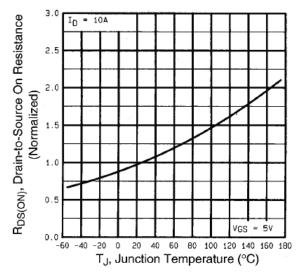


Fig. 4 - Normalized On-Resistance vs. Temperature



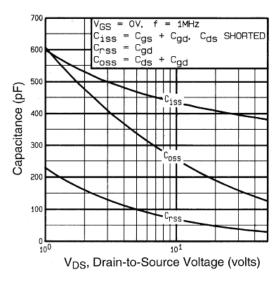


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

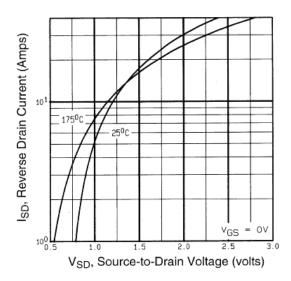


Fig. 7 - Typical Source-Drain Diode Forward Voltage

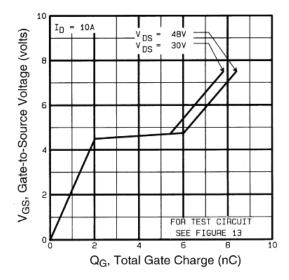


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

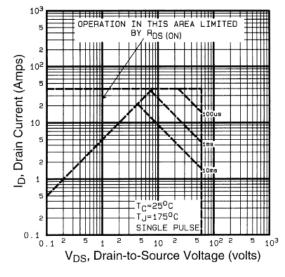


Fig. 8 - Maximum Safe Operating Area

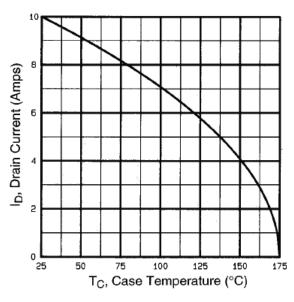


Fig. 9 - Maximum Drain Current vs. Case Temperature

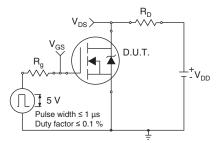


Fig. 10a - Switching Time Test Circuit

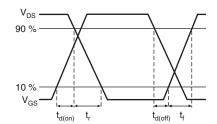


Fig. 10b - Switching Time Waveforms

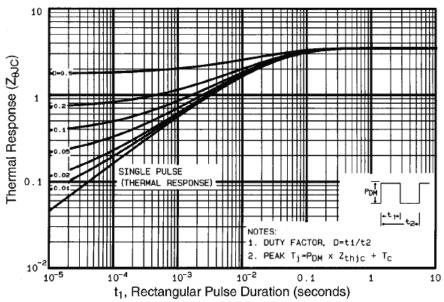
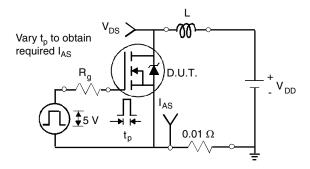


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case





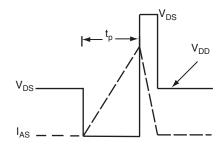


Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

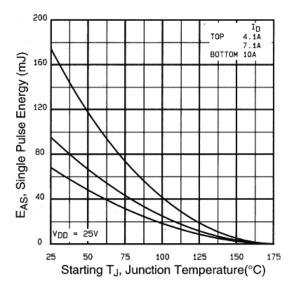


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

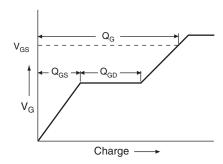


Fig. 13a - Basic Gate Charge Waveform

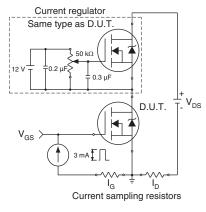
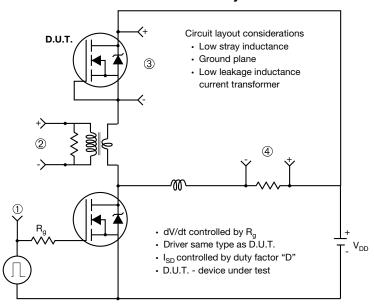


Fig. 13b - Gate Charge Test Circuit

### Peak Diode Recovery dV/dt Test Circuit



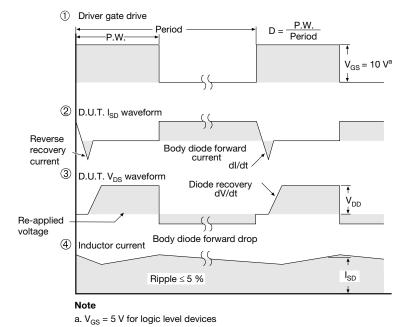
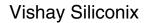


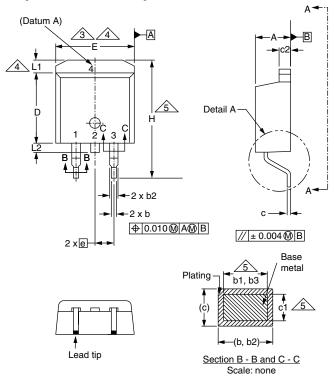
Fig. 14 - For N-Channel

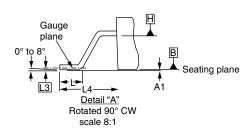
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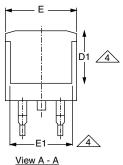




### **TO-263AB (HIGH VOLTAGE)**







	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	i
е	2.54	BSC	0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	i	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

### DWG: 5970

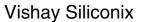
Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).

ECN: S-82110-Rev. A, 15-Sep-08

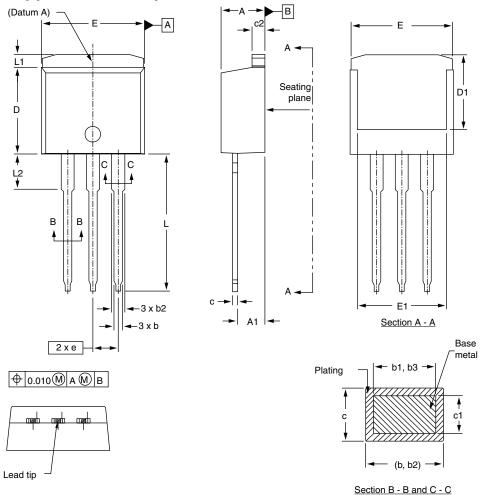
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

Document Number: 91364 www.vishay.com Revision: 15-Sep-08





### I<sup>2</sup>PAK (TO-262) (HIGH VOLTAGE)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54	BSC	0.100 BSC	
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.
- 4. Dimension b1 and c1 apply to base metal only.

Document Number: 91367 Revision: 27-Oct-08



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Vishay

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Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as RoHS-Compliant fulfill the definitions and restrictions defined under Directive 2011/65/EU of The European Parliament and of the Council of June 8, 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment (EEE) - recast, unless otherwise specified as non-compliant.

Please note that some Vishay documentation may still make reference to RoHS Directive 2002/95/EC. We confirm that all the products identified as being compliant to Directive 2002/95/EC conform to Directive 2011/65/EU.

Vishay Intertechnology, Inc. hereby certifies that all its products that are identified as Halogen-Free follow Halogen-Free requirements as per JEDEC JS709A standards. Please note that some Vishay documentation may still make reference to the IEC 61249-2-21 definition. We confirm that all the products identified as being compliant to IEC 61249-2-21 conform to JEDEC JS709A standards.

Revision: 02-Oct-12 Document Number: 91000